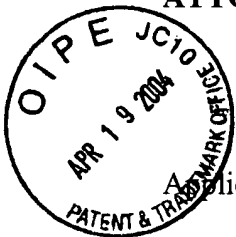


2625

ATTORNEY DOCKET NO. ANTONELL 3-1-18-1-20

PATENT



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

#3/a
mat
4/26/04

Applicant: Erik C. Houge, et al.

Serial No.: 09/809,379

Filed: March 15, 2001

Title: A METHOD FOR DETECTING DEFECTS IN A MATERIAL
AND A SYSTEM FOR ACCOMPLISHING THE SAME

Grp./A.U.: 2625

Examiner: John B. Strege

RECEIVED

APR 20 2004

Technology Center 2600

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

<p>I hereby certify that this correspondence is being deposited with the United States Postal Service as first class mail in an envelope addressed to: Commissioner for Patents, Alexandria, VA 22313, on</p> <p><u>4-16-2004</u> (Date)</p> <p><u>Elizabeth Schumacher</u> (Printed or typed name of person signing the certificate)</p> <p><u>Elizabeth Schumacher</u> (Signature of the person signing the certificate)</p>
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Sir:

AMENDMENT UNDER 37 C.F.R. § 1.111

In response to the Examiner's Action mailed February 11, 2004, please amend the above-identified application as follows: